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Nonlinear Terahertz pump-Terahertz probe Measurements of Semiconductor Carrier Dynamics HAIDAN WEN, AARON LINDENBERG¹, PULSE Center, Stanford Linear Accelerator Center, LINDENBERG LAB TEAM — A table-top terahertz (THz) source has been employed to study the nonlinear response of semiconductors to near-half-cycle femtosecond pulses in the THz regime. We report nonlinear field-induced changes in the far infrared absorption coefficient induced by THz pulses. The transmittance as the function of THz peak field was measured using a z-scan technique and it is observed that the absorption coefficient dramatically increases above a threshold field. Temperature-dependent pump-probe measurements indicate that free carriers are generated by the intense fields, as a result of field-induced tunneling and impact ionization processes.

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